



# STP/F21NM60ND-STW21NM60ND STB21NM60ND-STI21NM60ND

N-channel 600 V, 0.17  $\Omega$ , 17 A FDmesh™ II Power MOSFET  
D<sup>2</sup>PAK, I<sup>2</sup>PAK, TO-220FP, TO-220, TO-247

## Features

Type	V <sub>DSS</sub> @ T <sub>Jmax</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub>
STB21NM60ND	650 V	< 0.22 $\Omega$	17 A
STI21NM60ND	650 V	< 0.22 $\Omega$	17 A
STF21NM60ND	650 V	< 0.22 $\Omega$	17 A <sup>(1)</sup>
STP21NM60ND	650 V	< 0.22 $\Omega$	17 A
STW21NM60ND	650 V	< 0.22 $\Omega$	17 A

1. Limited only by maximum temperature allowed
- The worldwide best R<sub>DS(on)</sub>\*area amongst the fast recovery diode devices
  - 100% avalanche tested
  - Low input capacitance and gate charge
  - Low gate input resistance
  - Extremely high dv/dt and avalanche capabilities

## Application

- Switching applications

## Description

The FDmesh™ II series belongs to the second generation of MDmesh™ technology. This revolutionary Power MOSFET associates a new vertical structure to the company's strip layout and associates all advantages of reduced on-resistance and fast switching with an intrinsic fast-recovery body diode. It is therefore strongly recommended for bridge topologies, in ZVS phase-shift converters.

Table 1. Device summary

Order codes	Marking	Package	Packaging
STB21NM60ND	21NM60ND	D <sup>2</sup> PAK	Tape and reel
STI21NM60ND	21NM60ND	I <sup>2</sup> PAK	Tube
STF21NM60ND	21NM60ND	TO-220FP	Tube
STP21NM60ND	21NM60ND	TO-220	Tube
STW21NM60ND	21NM60ND	TO-247	Tube

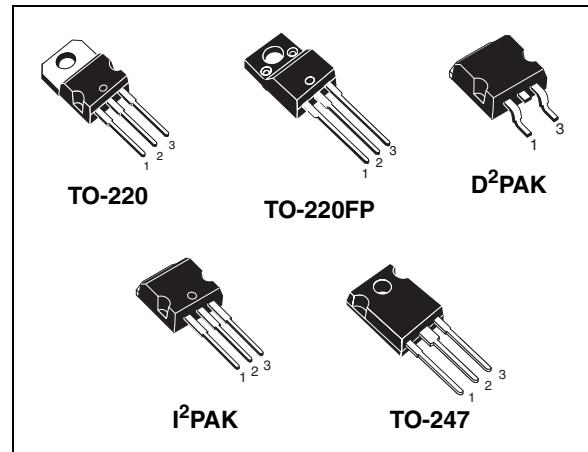
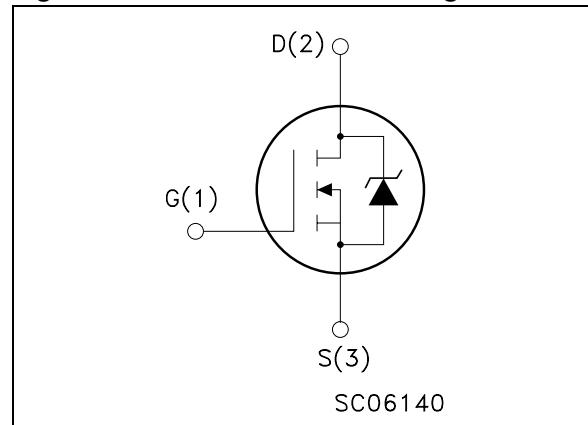


Figure 1. Internal schematic diagram



## Contents

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# 1 Electrical ratings

**Table 2. Absolute maximum ratings**

Symbol	Parameter	Value		Unit
		TO-220/D <sup>2</sup> PAK I <sup>2</sup> PAK / TO-247	TO-220FP	
V <sub>DS</sub>	Drain-source voltage ( $V_{GS} = 0$ )	600		V
V <sub>GS</sub>	Gate- source voltage	±25		V
I <sub>D</sub>	Drain current (continuous) at $T_C = 25\text{ }^\circ\text{C}$	17	17 <sup>(1)</sup>	A
I <sub>D</sub>	Drain current (continuous) at $T_C = 100\text{ }^\circ\text{C}$	10	10 <sup>(1)</sup>	A
I <sub>DM</sub> <sup>(2)</sup>	Drain current (pulsed)	68	68 <sup>(1)</sup>	A
P <sub>TOT</sub>	Total dissipation at $T_C = 25\text{ }^\circ\text{C}$	140	30	W
dv/dt <sup>(3)</sup>	Peak diode recovery voltage slope	40		V/ns
V <sub>iso</sub>	Insulation withstand voltage (RMS) from all three leads to external heat sink ( $t=1\text{ s}; T_C=25\text{ }^\circ\text{C}$ )	--	2500	V
T <sub>stg</sub>	Storage temperature	−55 to 150		°C
T <sub>J</sub>	Max. operating junction temperature	150		

1. Limited only by maximum temperature allowed
2. Pulse width limited by safe operating area
3.  $I_{SD} \leq 17\text{ A}$ ,  $dI/dt \leq 600\text{ A}/\mu\text{s}$ ,  $V_{DD} = 80\%$   $V_{(BR)DSS}$

**Table 3. Thermal data**

Symbol	Parameter	TO-220	D <sup>2</sup> PAK	I <sup>2</sup> PAK	TO-247	TO-220FP	Unit
R <sub>thj-case</sub>	Thermal resistance junction-case max			0.89		4.17	°C/W
R <sub>thj-amb</sub>	Thermal resistance junction-ambient max	62.5	--	62.5	50	62.5	°C/W
T <sub>I</sub>	Maximum lead temperature for soldering purpose			300			°C

**Table 4. Avalanche characteristics**

Symbol	Parameter	Max value	Unit
I <sub>AS</sub>	Avalanche current, repetitive or not-repetitive (pulse width limited by T <sub>J</sub> max)	8.5	A
E <sub>AS</sub>	Single pulse avalanche energy (starting T <sub>J</sub> = 25 °C, I <sub>D</sub> = I <sub>AS</sub> , V <sub>DD</sub> = 50 V)	610	mJ

## 2 Electrical characteristics

( $T_{CASE}=25^{\circ}\text{C}$  unless otherwise specified)

**Table 5. On/off states**

<b>Symbol</b>	<b>Parameter</b>	<b>Test conditions</b>	<b>Value</b>			<b>Unit</b>
			<b>Min.</b>	<b>Typ.</b>	<b>Max.</b>	
$V_{(BR)DSS}$	Drain-source breakdown voltage	$I_D = 1 \text{ mA}, V_{GS} = 0$	600			V
$dv/dt^{(1)}$	Drain source voltage slope	$V_{DD} = 480 \text{ V}, I_D = 17 \text{ A}, V_{GS} = 10 \text{ V}$	48			V/ns
$I_{DSS}$	Zero gate voltage drain current ( $V_{GS} = 0$ )	$V_{DS} = \text{Max rating}$ $V_{DS} = \text{Max rating} @ 125^{\circ}\text{C}$			1 100	$\mu\text{A}$ $\mu\text{A}$
$I_{GSS}$	Gate-body leakage current ( $V_{DS} = 0$ )	$V_{GS} = \pm 20 \text{ V}$			100	nA
$V_{GS(\text{th})}$	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	3	4	5	V
$R_{DS(\text{on})}$	Static drain-source on resistance	$V_{GS} = 10 \text{ V}, I_D = 8.5 \text{ A}$		0.170	0.220	$\Omega$

1. Characteristic value at turn off on inductive load

**Table 6. Dynamic**

<b>Symbol</b>	<b>Parameter</b>	<b>Test conditions</b>	<b>Min.</b>	<b>Typ.</b>	<b>Max.</b>	<b>Unit</b>
$g_{fs}^{(1)}$	Forward transconductance	$V_{DS} = 15 \text{ V}, I_D = 8 \text{ A}$		12		s
$C_{iss}$ $C_{oss}$ $C_{rss}$	Input capacitance Output capacitance Reverse transfer capacitance	$V_{DS} = 50 \text{ V}, f = 1 \text{ MHz}, V_{GS} = 0$		1800 90 8		pF pF pF
$C_{oss \text{ eq.}}^{(2)}$	Equivalent output capacitance	$V_{GS} = 0, V_{DS} = 0 \text{ to } 480 \text{ V}$		300		pF
$t_{d(on)}$ $t_r$ $t_{d(off)}$ $t_f$	Turn-on delay time Rise time Turn-off delay time Fall time	$V_{DD} = 300 \text{ V}, I_D = 8.5 \text{ A}$ $R_G = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see Figure 23), (see Figure 18)		18 16 70 48		ns ns ns ns
$Q_g$ $Q_{gs}$ $Q_{gd}$	Total gate charge Gate-source charge Gate-drain charge	$V_{DD} = 480 \text{ V}, I_D = 17 \text{ A}, V_{GS} = 10 \text{ V}$ (see Figure 19)		60 10 30		nC nC nC
$R_g$	Gate input resistance	f=1 MHz Gate DC Bias=0 Test signal level=20 mV Open drain		3		$\Omega$

1. Pulsed: pulse duration=300 $\mu$ s, duty cycle 1.5%

2.  $C_{oss \text{ eq.}}$  is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$

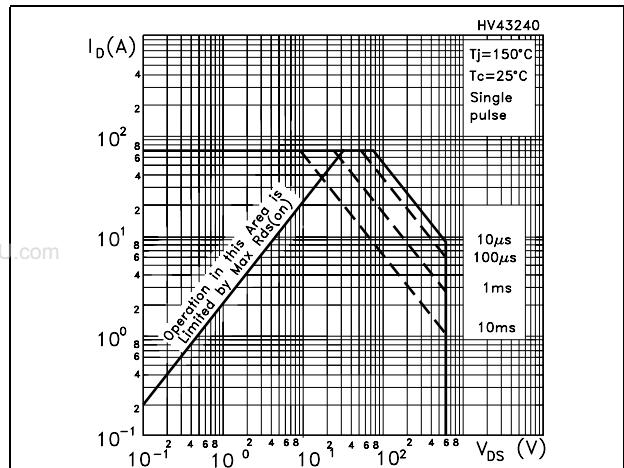
**Table 7. Source drain diode**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_{SD}$	Source-drain current			17	A	
$I_{SDM}^{(1)}$	Source-drain current (pulsed)			68	A	
$V_{SD}^{(2)}$	Forward on voltage	$I_{SD} = 17 \text{ A}, V_{GS} = 0$		1.6	V	
$t_{rr}$	Reverse recovery time	$I_{SD} = 17 \text{ A}, V_{DD} = 60 \text{ V}$	150		ns	
$Q_{rr}$	Reverse recovery charge	$di/dt = 100 \text{ A}/\mu\text{s}$	0.90		$\mu\text{C}$	
$I_{RRM}$	Reverse recovery current	(see Figure 20)	13		A	
$t_{rr}$	Reverse recovery time	$I_{SD} = 17 \text{ A}, V_{DD} = 60 \text{ V}$	210		ns	
$Q_{rr}$	Reverse recovery charge	$di/dt = 100 \text{ A}/\mu\text{s},$	1.6		$\mu\text{C}$	
$I_{RRM}$	Reverse recovery current	$T_J = 150 \text{ }^\circ\text{C}$ (see Figure 20)	15		A	

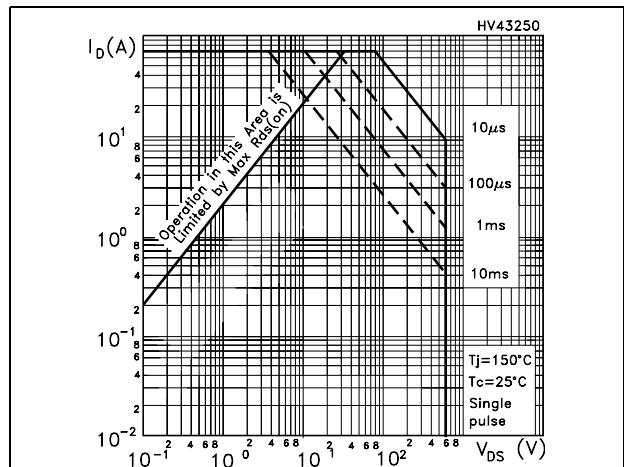
1. Pulse width limited by safe operating area
2. Pulsed: Pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%.

## 2.1 Electrical characteristics (curves)

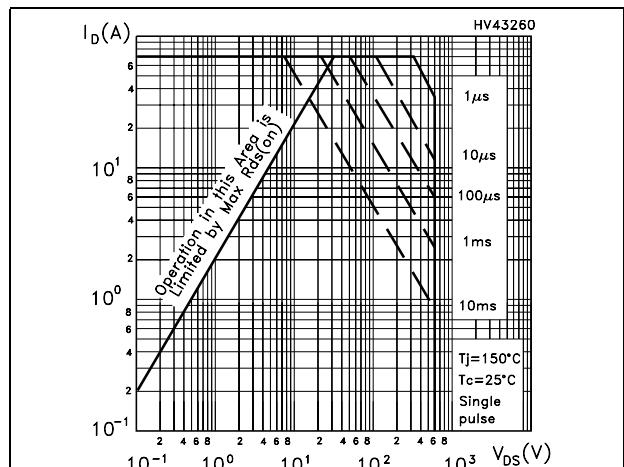
**Figure 2.** Safe operating area for TO-220 / D<sup>2</sup>PAK / I<sup>2</sup>PAK



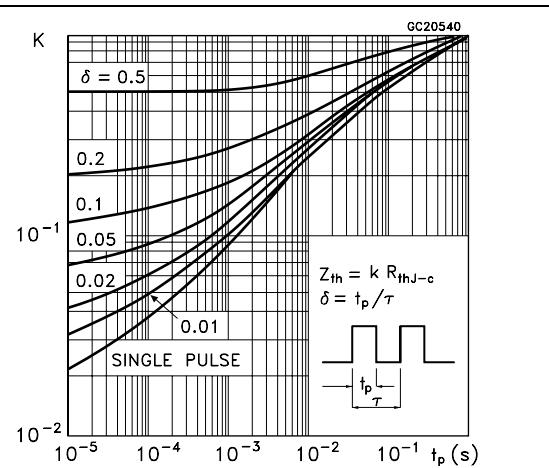
**Figure 4.** Safe operating area for TO-220FP



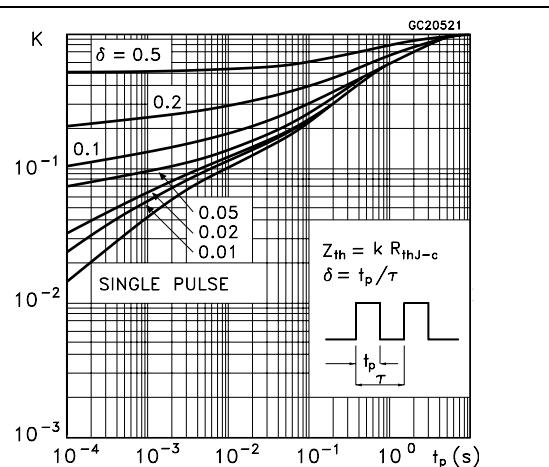
**Figure 6.** Safe operating area for TO-247



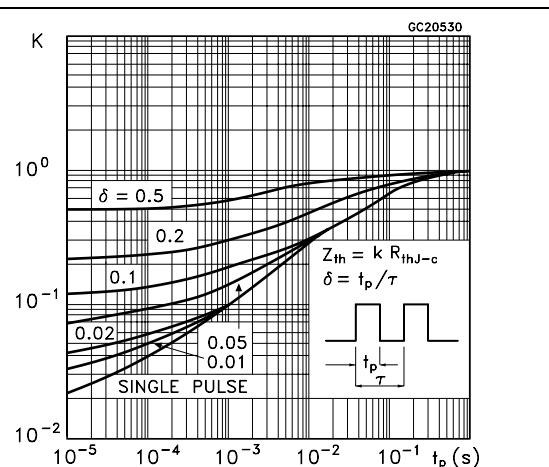
**Figure 3.** Thermal impedance for TO-220 / D<sup>2</sup>PAK / I<sup>2</sup>PAK

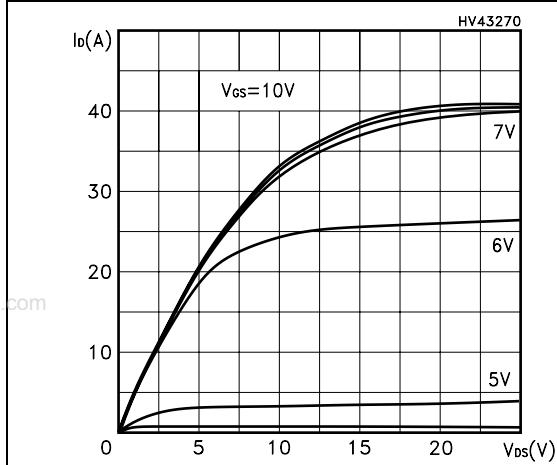
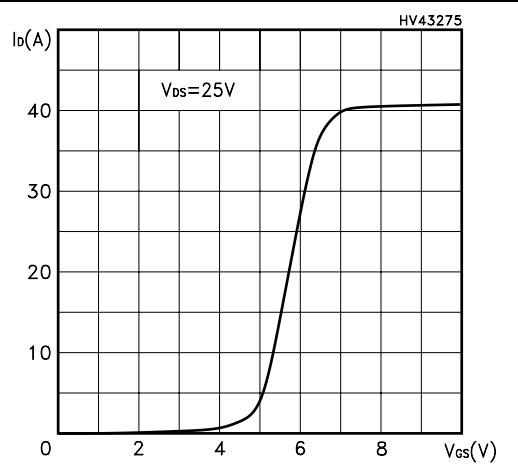
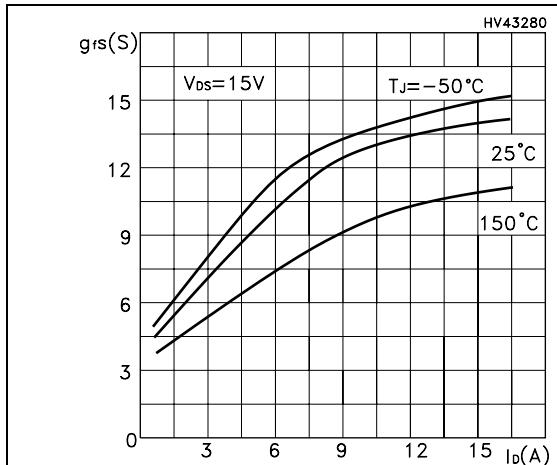
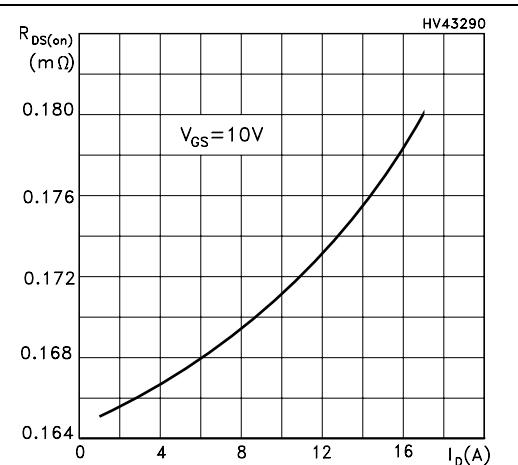
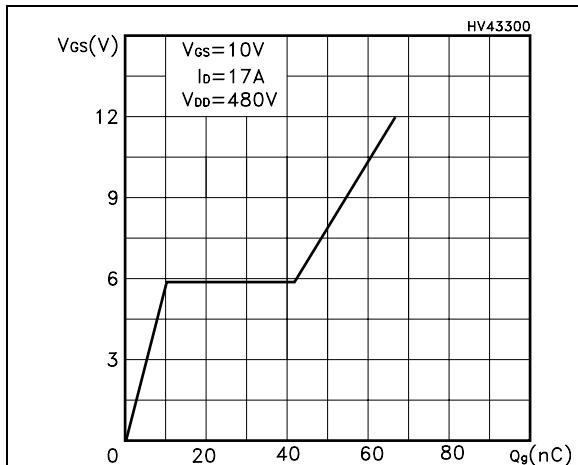
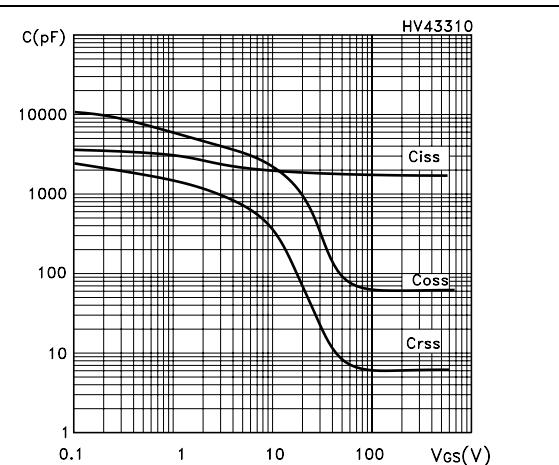


**Figure 5.** Thermal impedance for TO-220FP

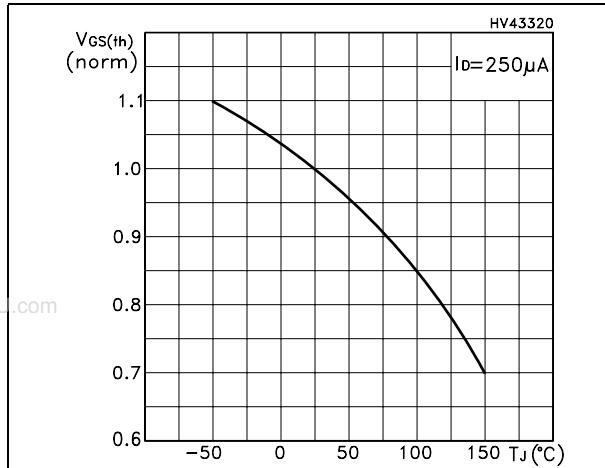


**Figure 7.** Thermal impedance for TO-247

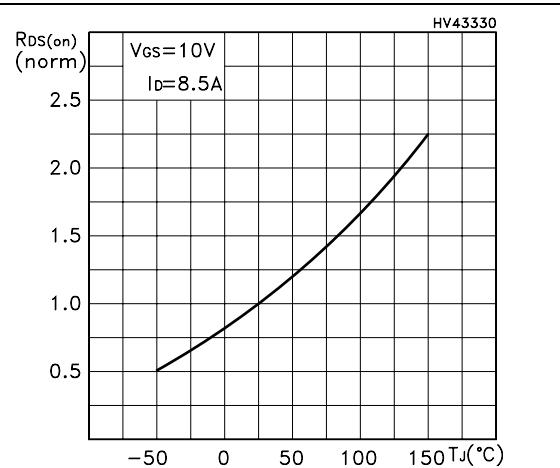


**Figure 8. Output characteristics****Figure 9. Transfer characteristics****Figure 10. Transconductance****Figure 11. Static drain-source on resistance****Figure 12. Gate charge vs gate-source voltage****Figure 13. Capacitance variations**

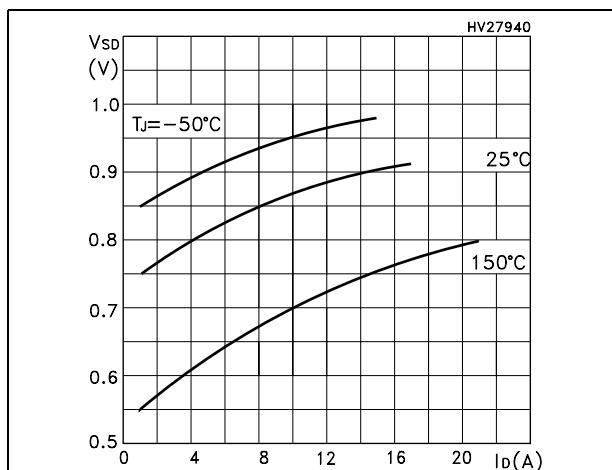
**Figure 14. Normalized gate threshold voltage vs temperature**



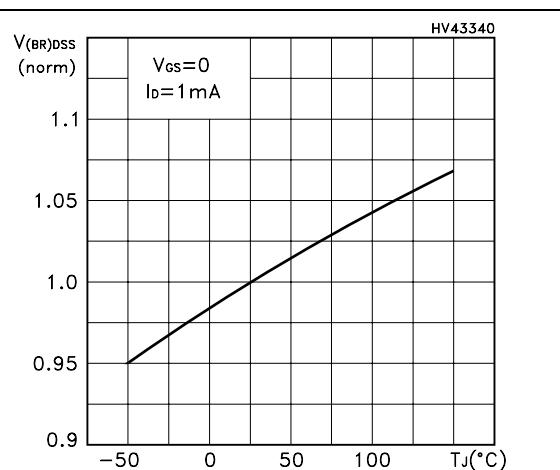
**Figure 15. Normalized on resistance vs temperature**



**Figure 16. Source-drain diode forward characteristics**

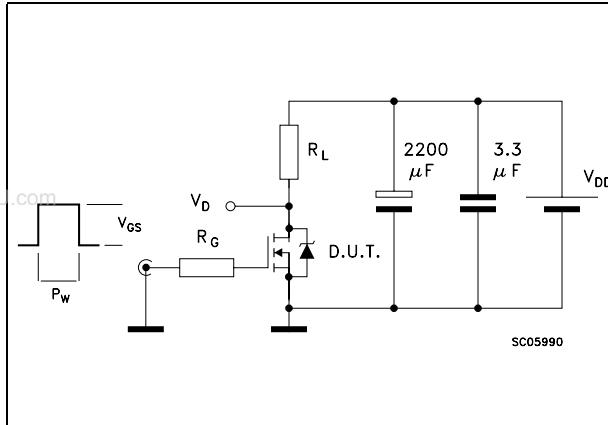


**Figure 17. Normalized  $BV_{DSS}$  vs temperature**

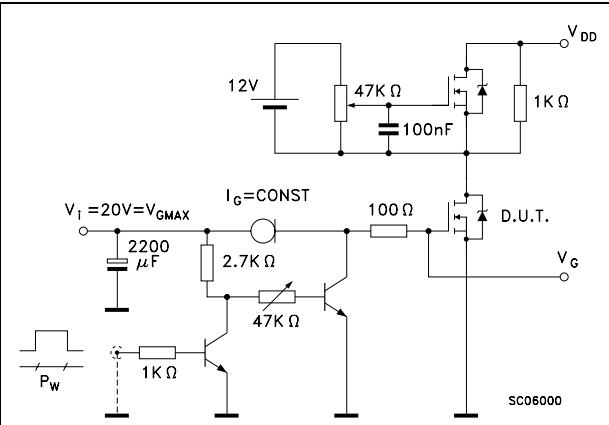


### 3 Test circuits

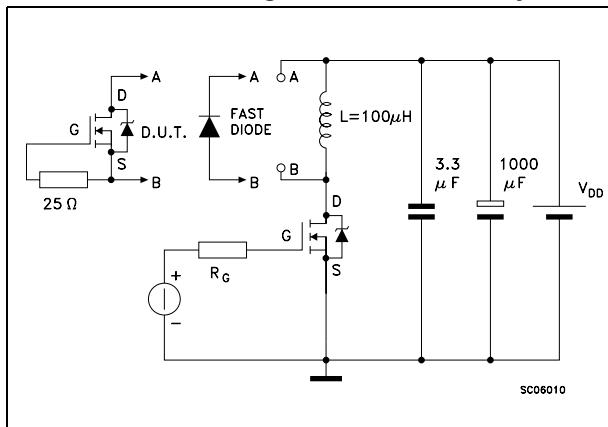
**Figure 18. Switching times test circuit for resistive load**



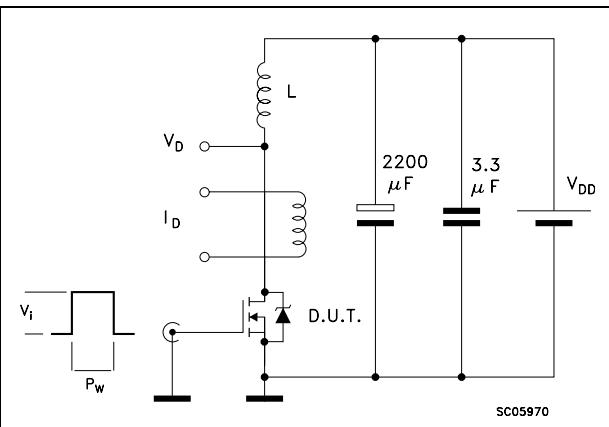
**Figure 19. Gate charge test circuit**



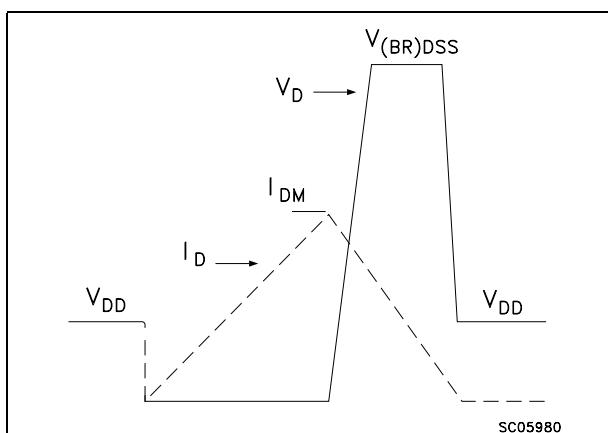
**Figure 20. Test circuit for inductive load switching and diode recovery times**



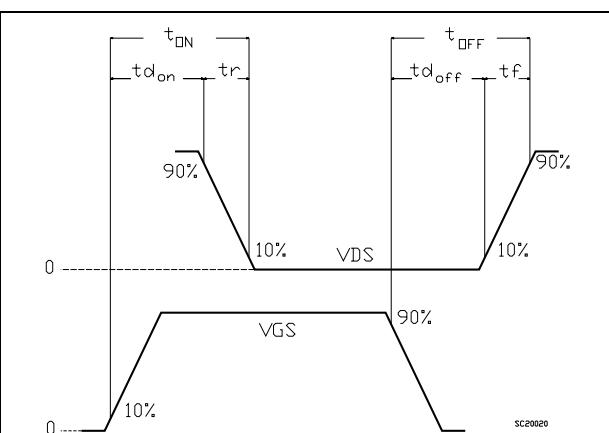
**Figure 21. Unclamped Inductive load test circuit**



**Figure 22. Unclamped inductive waveform**



**Figure 23. Switching time waveform**

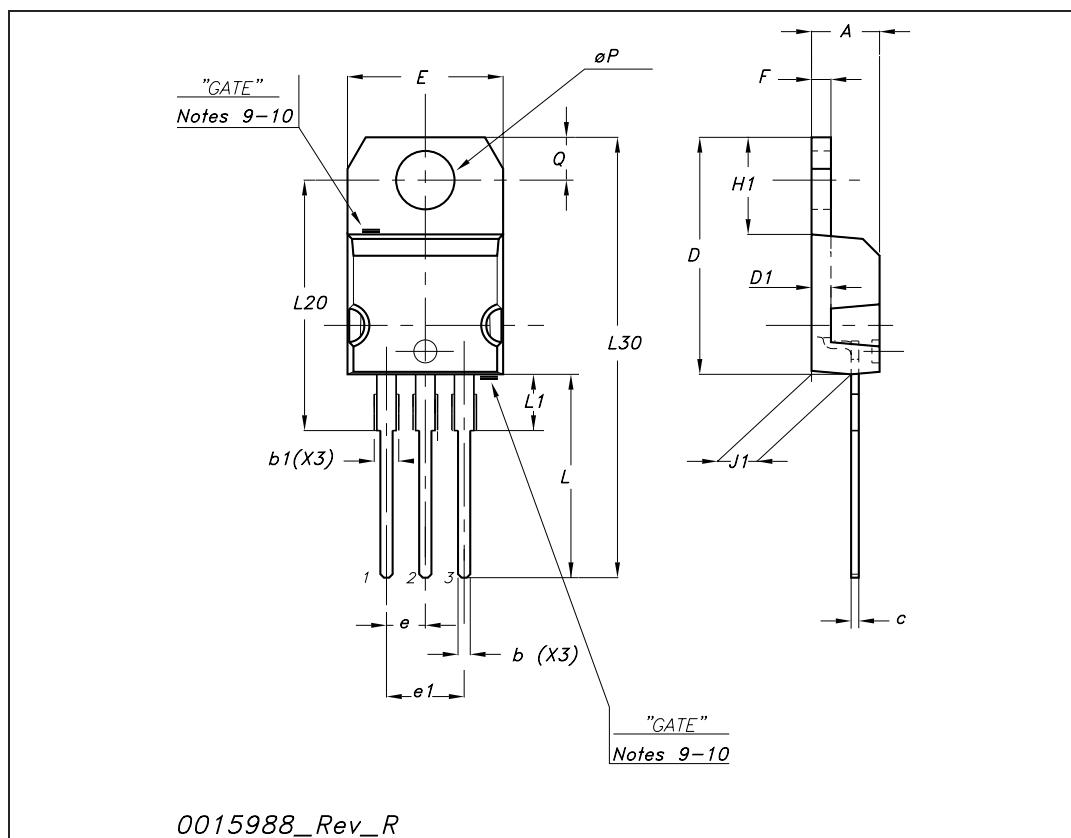


## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: [www.st.com](http://www.st.com)

## TO-220 mechanical data

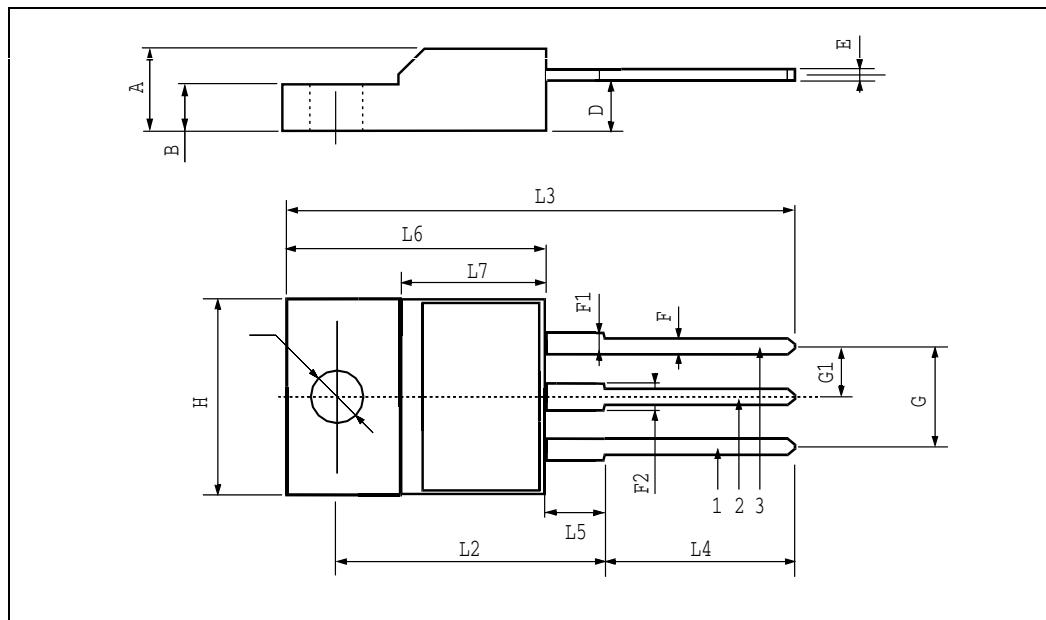
Dim	mm			inch		
	Min	Typ	Max	Min	Typ	Max
A	4.40		4.60	0.173		0.181
b	0.61		0.88	0.024		0.034
b1	1.14		1.70	0.044		0.066
c	0.48		0.70	0.019		0.027
D	15.25		15.75	0.6		0.62
D1		1.27			0.050	
E	10		10.40	0.393		0.409
e	2.40		2.70	0.094		0.106
e1	4.95		5.15	0.194		0.202
F	1.23		1.32	0.048		0.051
H1	6.20		6.60	0.244		0.256
J1	2.40		2.72	0.094		0.107
L	13		14	0.511		0.551
L1	3.50		3.93	0.137		0.154
L20		16.40			0.645	
L30		28.90			1.137	
$\emptyset P$	3.75		3.85	0.147		0.151
Q	2.65		2.95	0.104		0.116



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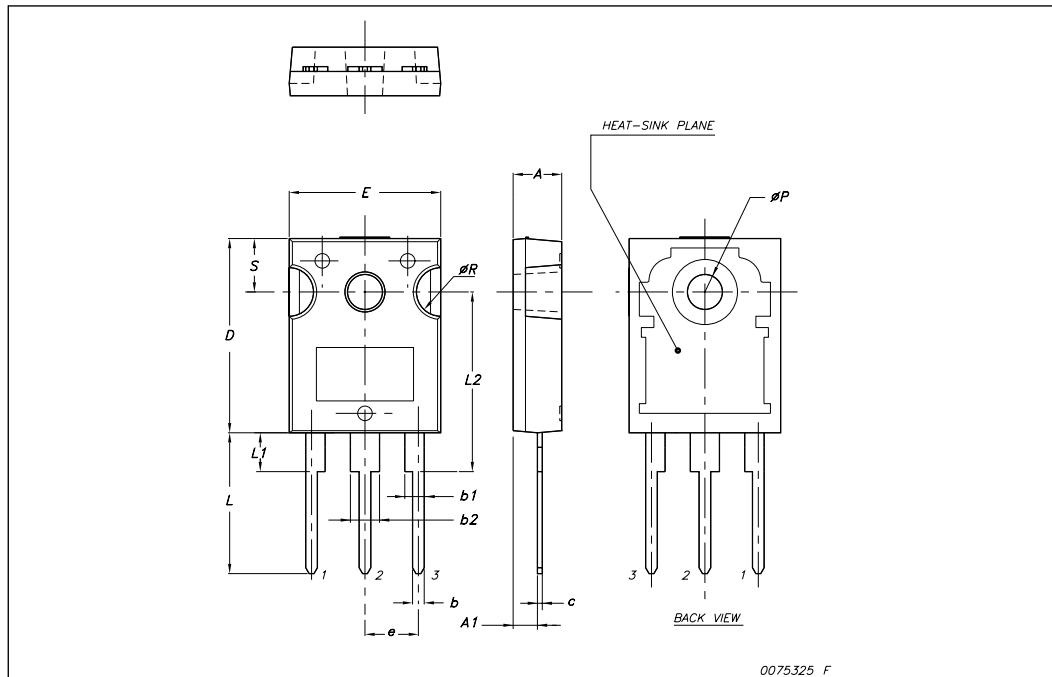
**TO-220FP mechanical data**

DIM.	mm.			inch		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A	4.4		4.6	0.173		0.181
B	2.5		2.7	0.098		0.106
D	2.5		2.75	0.098		0.108
E	0.45		0.7	0.017		0.027
F	0.75		1	0.030		0.039
F1	1.15		1.7	0.045		0.067
F2	1.15		1.7	0.045		0.067
G	4.95		5.2	0.195		0.204
G1	2.4		2.7	0.094		0.106
H	10		10.4	0.393		0.409
L2		16			0.630	
L3	28.6		30.6	1.126		1.204
L4	9.8		10.6	.0385		0.417
L5	2.9		3.6	0.114		0.141
L6	15.9		16.4	0.626		0.645
L7	9		9.3	0.354		0.366
Ø	3		3.2	0.118		0.126



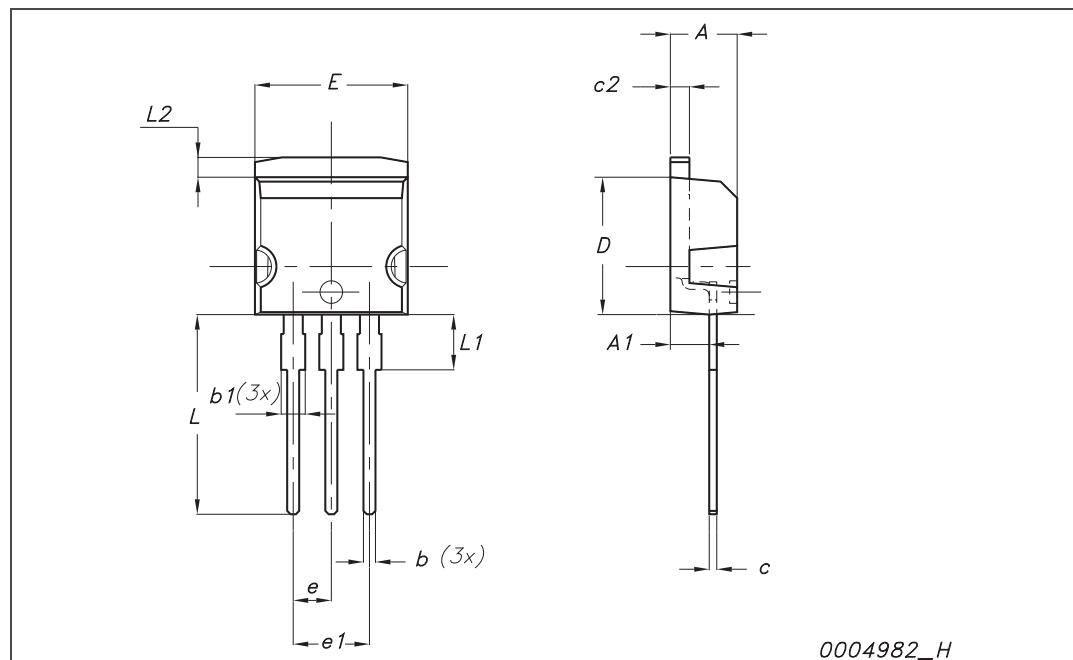
## TO-247 Mechanical data

Dim.	mm.		
	Min.	Typ	Max.
A	4.85		5.15
A1	2.20		2.60
b	1.0		1.40
b1	2.0		2.40
b2	3.0		3.40
c	0.40		0.80
D	19.85		20.15
E	15.45		15.75
e		5.45	
L	14.20		14.80
L1	3.70		4.30
L2		18.50	
øP	3.55		3.65
øR	4.50		5.50
S		5.50	



I<sup>2</sup>PAK (TO-262) mechanical data

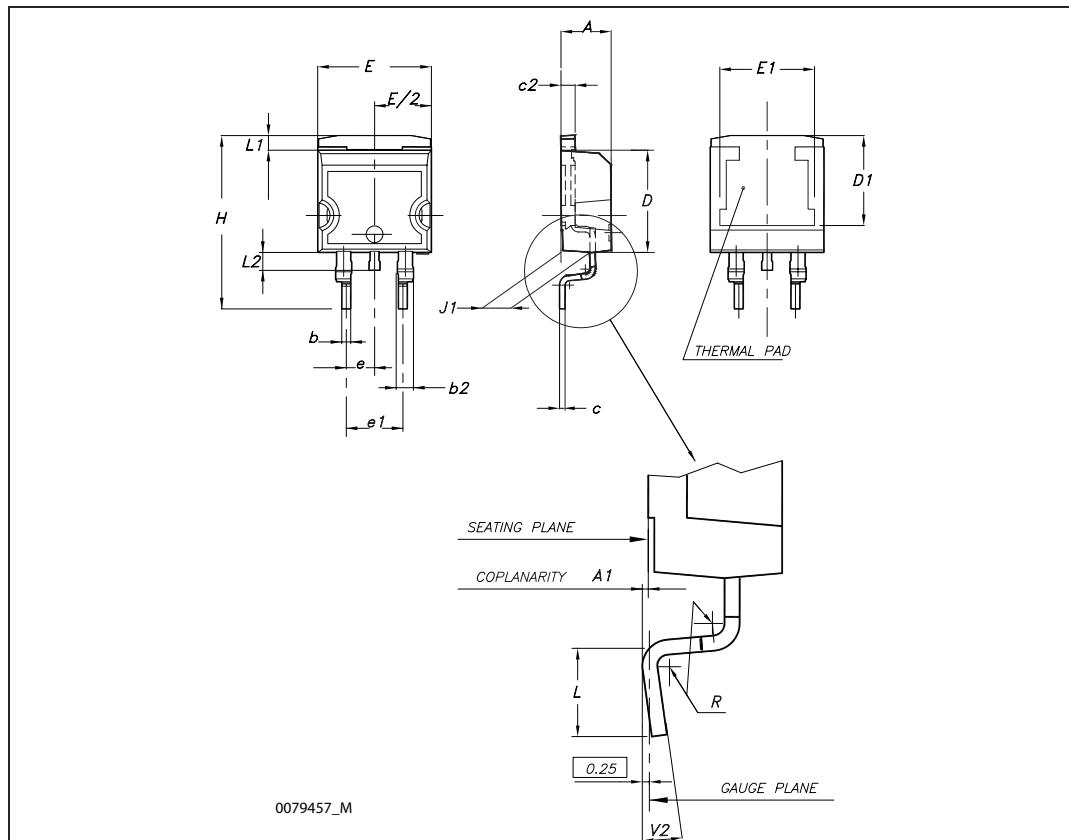
Dim	mm			inch		
	Min	Typ	Max	Min	Typ	Max
A	4.40		4.60	0.173		0.181
A1	2.40		2.72	0.094		0.107
b	0.61		0.88	0.024		0.034
b1	1.14		1.70	0.044		0.066
c	0.49		0.70	0.019		0.027
c2	1.23		1.32	0.048		0.052
D	8.95		9.35	0.352		0.368
e	2.40		2.70	0.094		0.106
e1	4.95		5.15	0.194		0.202
E	10		10.40	0.393		0.410
L	13		14	0.511		0.551
L1	3.50		3.93	0.137		0.154
L2	1.27		1.40	0.050		0.055



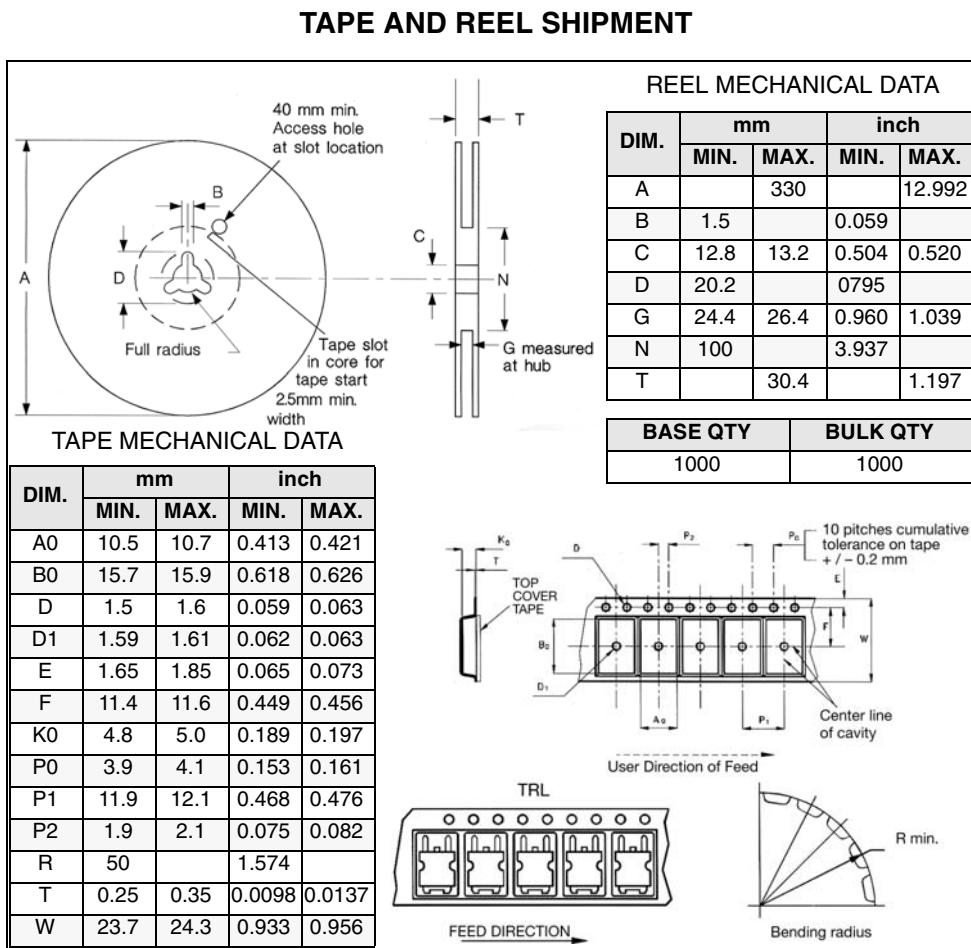
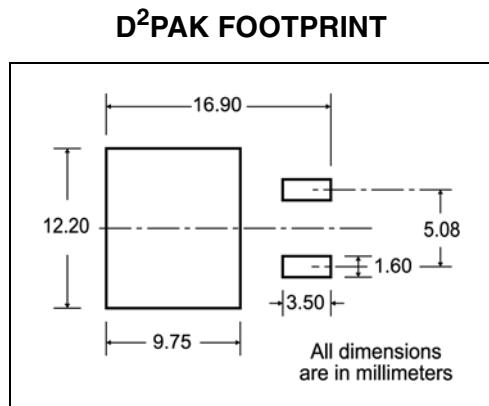
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D<sup>2</sup>PAK (TO-263) mechanical data

Dim	mm			inch		
	Min	Typ	Max	Min	Typ	Max
A	4.40		4.60	0.173		0.181
A1	0.03		0.23	0.001		0.009
b	0.70		0.93	0.027		0.037
b2	1.14		1.70	0.045		0.067
c	0.45		0.60	0.017		0.024
c2	1.23		1.36	0.048		0.053
D	8.95		9.35	0.352		0.368
D1	7.50			0.295		
E	10		10.40	0.394		0.409
E1	8.50			0.334		
e		2.54			0.1	
e1	4.88		5.28	0.192		0.208
H	15		15.85	0.590		0.624
J1	2.49		2.69	0.099		0.106
L	2.29		2.79	0.090		0.110
L1	1.27		1.40	0.05		0.055
L2	1.30		1.75	0.051		0.069
R		0.4			0.016	
V2	0°		8°	0°		8°



## 5 Packing mechanical data



\* on sales type

## 6 Revision history

**Table 8. Document revision history**

Date	Revision	Changes
05-Sep-2007	1	First release.
22-Apr-2008	2	Datasheet status promoted from preliminary data to datasheet.

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